Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10529517	IKEDA ET AL.
Examiner	Art Unit
HENOK G HEYI	2627

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SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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Searched EAST, specifically 369/30.13 (text search only - please see search history printout)	02/27/2009	НН

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